## Application/Control No. Applicant(s)/Patent Under Reexamination 10/617,239 OHGAMI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Deborah Yee 1742 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α В US-US-C D US-US-Ε F US-US-G Н US-US-US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 411012684 01-1999 Japan Yasuki et al c22c 38/00 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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